Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/080,246	HIRUMI ET AL.	
Examiner	Art Unit	
Huan H. Tran	2861	

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Class	Subclass	Date	Examiner
347	171	5/25/2006	ннт
400	120.01	5/25/2006	ннт

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
Interference search_see search history printout		5/25/2006	ннт	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST text search (US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM TDB)_see search history printout	10/27/2005	ннт	
EAST text search updated_see search history printout	5/25/2006	ннт	